



Tuning of CeO₂ buffer layers for coated superconductors through doping

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ABSTRACT

The appearance of microcracks in cerium oxide (CeO₂) buffer layers, as used in buffer layer architectures for coated superconductors, indicates the presence of stress between this buffer layer and the substrate. This stress can originate from the differences in thermal expansion or differences in lattice parameters between the CeO₂ buffer layer and the substrate. In this article, we study, by means of *ab initio* density functional theory calculations, the influence of group IV doping elements on the lattice parameter and bulk modulus of CeO₂. Vegard's law behavior is found for the lattice parameter in systems without oxygen vacancies, and the Shannon crystal radii for the doping elements are retrieved from the lattice expansions. We show that the lattice parameter of the doped CeO₂ can be matched to that of the La₂Zr₂O₇ coated NiW substrate substrate for dopant concentrations of about 5%, and that bulk modulus matching is either not possible or would require extreme doping concentrations.

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1. Introduction

Cerium-oxide-based materials have attracted increasing interest over the last two decades. This is mainly due to their remarkable properties with regard to oxidation–reduction catalysis. They are used in a number of industrial applications: three-way catalysts [1], oxygen sensors, solid-oxide fuel cells [2,3], and many more [4–6]. More recently, cerium oxide (CeO₂) has been used as thin film buffer layer in YBa₂Cu₃O_{7–δ} (YBCO) coated superconductors (CSC) [7–12]. In a YBCO–CSC architecture, a YBCO thin film is grown on a metallic substrate. To prevent the metal atoms of diffusing into the YBCO, one or more buffer layers are required. In addition, these buffer layers also prevent the oxidation of the metallic substrate during YBCO deposition. Due to its structural compatibility with YBCO, CeO₂ is preferred as the top layer in a multilayer architecture. However, the layer thickness of the CeO₂ buffer layer is limited by the formation of cracks during deposition [7,8]. This phenomenon has been linked to internal stress due to lattice mismatch or different thermal expansion coefficients of the substrate and the CeO₂ buffer layer [8,11]. A simple way to reduce the mismatch and stress is through doping [9–11].

In this paper, we study the influence of doping on this mismatch and stress using *ab initio* atomistic calculations. The energetics and

electronic properties of doped systems and the influence of oxygen vacancies is beyond the scope of this work and will be discussed elsewhere.

The stress due to volumetric changes, which are present during the heating and cooling cycles of the production process, are investigated through the bulk moduli (BM) of the doped systems. Because the CeO₂ buffer layer is often grown on a La₂Zr₂O₇ (LZO) buffer layer in multilayer architectures, a match with the LZO bulk modulus will reduce the inter-layer stress. The change in the CeO₂ lattice parameter is derived directly from the calculated atomic structure, and a match with the LZO lattice parameter is searched for to reduce inter-layer stress due to lattice mismatch.

Because Ce is tetravalent in CeO₂, group IV elements are an obvious choice as doping elements. They have the additional advantage that no extra oxygen vacancies need to be introduced for charge compensation. This allows us to retain a clear picture of the direct effects on the lattice parameter and bulk modulus due to the doping elements themselves.

We also look at the effect of aliovalent dopants (Cu, Zn, and La), assuming oxidized systems without the presence of charge compensating vacancies. This corresponds with experimental systems under (strongly) oxidizing atmosphere. Comparison to results of the group IV elements shows that the valency has relatively little influence.

For such homogeneous systems without oxygen vacancies, it is possible to study the crystal structure from a purely analytic perspective, and we derive Vegard's empirical law analytically for these systems.

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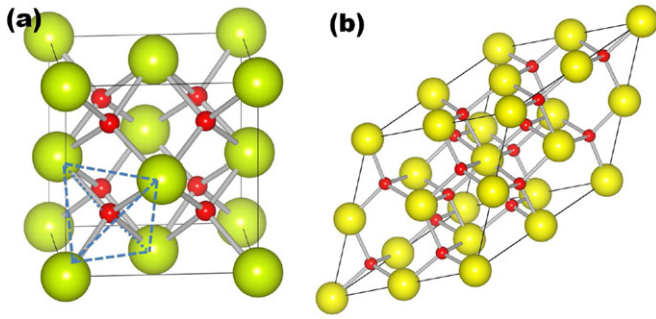


Fig. 1. Ball-and-stick model presenting the CeO₂ cubic fluorite structure supercells (a) c111 and (b) p222 (cf. text). The big yellow and small red spheres indicate the positions of the Ce and O atoms, respectively. The tetrahedral surrounding of a single O atom is indicated by the tetrahedron for the c111 supercell. (Color online.)

2. Theoretical method

We perform *ab initio* density functional theory (DFT) calculations within the projector augmented-wave method as implemented in the Vienna *ab initio* Package (VASP) program [13,14]. The local density approximation (LDA) functional as parameterized by Ceperley and Alder and the generalized gradient approximation (GGA) functional as constructed by Perdew, Burke and Ernzerhof (PBE) are used as exchange-correlation functionals [15–18]. Since our focus goes mainly to the mechanical and structural properties of the system this should be sufficient, and no additional Coulomb correction is required. The plane wave kinetic energy cutoff is set to 500 eV.

Symmetric supercells, containing a single dopant per supercell are used to simulate homogeneous distributions of the dopants. The supercells used are the fluorite cubic $1 \times 1 \times 1$ cell with 12 atoms (c111), shown in Fig. 1a, the primitive $2 \times 2 \times 2$ cell with 24 atoms (p222), shown in Fig. 1b, the primitive $3 \times 3 \times 3$ cell with 81 atoms (p333), not shown, and the cubic $2 \times 2 \times 2$ cell with 96 atoms (c222), not shown. Replacing a single Ce atom results in dopant concentrations of 25.0, 12.5, 3.7, and 3.1 %, respectively. Monkhorst–Pack special k -point grids are used to sample the Brillouin zone [19]. For the two smaller cells we use an $8 \times 8 \times 8$ k -point grid while for the two large supercells a $4 \times 4 \times 4$ k -point grid is used. To optimize the structures, a conjugate gradient method is used. During relaxation both atom positions and cell geometry are allowed to change simultaneously. The convergence criterion is set to the difference in energy between subsequent steps becoming smaller than 1.0×10^{-6} eV.

For each dopant the bulk modulus is calculated by fitting $E(V)$ data from fixed volume calculations to the third order isothermal Birch–Murnaghan equation of state [20,21]. To reduce the computational cost, dopant concentrations of 25% are used.

Ball-and-stick images of the crystal structures are generated using the VESTA visualization tool [22].

3. Results and discussion

3.1. Analytic derivation of Vegard's law

CeO₂ is known to have a cubic fluorite structure (space group $Fm\bar{3}m$). Fig. 1a shows the c111 supercell. Since every O atom is tetrahedrally surrounded by Ce atoms, the following relation can be derived from the Ce–O bond length:

$$R_O + R_{Ce} = a_{CeO_2} \frac{\sqrt{3}}{4}, \quad (1)$$

with R_O and R_{Ce} the atomic crystal radii of O and Ce respectively, and a_{CeO_2} the CeO₂ lattice parameter. For a cubic system, this allows

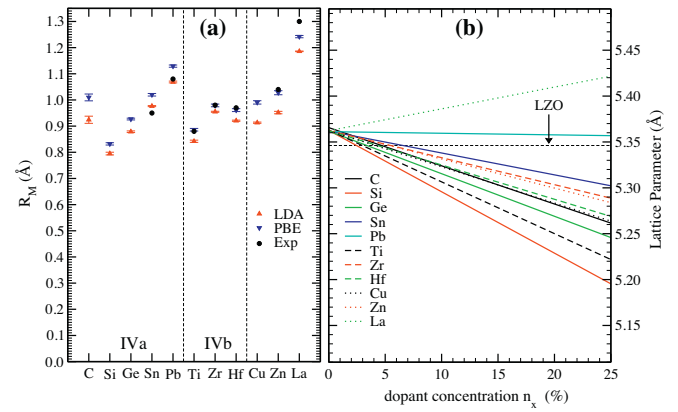


Fig. 2. (a) The dopant radii calculated using Eq. (2) for both the LDA and PBE results. The standard deviation is shown as error bars, and, where available, the experimental Shannon crystal radii R_{sh}^8 (cf. Table 1) are shown as reference. (b) The lattice parameter as function of the dopant concentration, calculated using Eq. (3). Only the LDA results are shown. The LZO half lattice parameter is shown as reference.

us to calculate the atomic crystal radius R_M of a Ce substituent M via:

$$R_M = \frac{(\frac{\sqrt{3}}{4} a_{M_xCe_{1-x}O_2} - R_O - (1 - n_x)R_{Ce})}{n_x} \quad (2)$$

with $a_{M_xCe_{1-x}O_2}$ the lattice parameter of the doped system and n_x the dopant concentration. The lattice parameter of the doped system can now be found by combining Eqs. (1) and (2):

$$a_{M_xCe_{1-x}O_2} = a_{CeO_2} + (\frac{4}{\sqrt{3}}(R_O + R_M) - a_{CeO_2})n_x. \quad (3)$$

This results in a clear linear relation between the lattice expansion/contraction of CeO₂ and the dopant concentration which is known as Vegard's empirical law [23]. These analytical results show Vegard's law behavior should be expected when the dopants are homogeneously distributed in CeO₂ in case of tetravalent dopants, but also for non-tetravalent dopants this behavior should be expected under oxidizing conditions.

Although Eqs. (2) and (3) can be derived from one another, the latter is more interesting from the experimental point of view, since lattice parameters and concentrations are readily available while atomic radii are not. Values for the two radii R_O and R_M can be taken from tabulated values for atomic radii. This, however, can be problematic since there are several different definitions for 'atomic radius' available, giving values which can easily differ 20%.¹ In light of this problem, Eq. (2) becomes interesting. It could tell us which definition of atomic radius to use for the doped CeO₂ systems. This would allow one to predict the Vegard's law behavior for any doped CeO₂ system prior to its synthesis.

3.2. Group IV elements

Using Eq. (2) we have calculated the atomic crystal radius for each of the four concentrations for each group IV element. The average values and their standard deviations are shown in Table 1 and Fig. 2a. In these calculations we have used the Shannon crystal radius for four-coordinate O²⁻; $R_O = 1.24$ Å. The radius of eight-coordinate Ce⁴⁺ is calculated from the non-doped CeO₂ system using Eq. (1) and shows very good agreement with the Shannon crystal radius for eight-coordinate Ce⁴⁺ [26,27]. For the group IV elements, the LDA and PBE calculations show the same relative trends,

¹ E.g. for oxygen one finds the calculated atomic radius to be 0.48 Å while the empirical atomic radius is given to be 0.60 Å [24,25].

Table 1
Dopant radii calculated using Eq. (2), averaged over the four dopant concentrations (avg), and standard deviation (stdev) of this value. This is done for both LDA and PBE calculated geometries. The Shannon crystal radii for the 8-coordinated tetravalent atoms R_{sh}^8 , taken from Ref. [26], are shown in comparison. a_0 and b are the intercept and slope of the Vegard's law linear fit to the calculated geometries for doped CeO_2 systems. The bulk moduli are calculated for dopant concentrations of 25%. The lattice parameter and bulk modulus (BM) calculated for pure CeO_2 and $La_2Zr_2O_7$ (LZO) are given as reference.

	R_M (Å)		R_{sh}^8		Vegard's Law				BM (Mbar)		
	LDA		PBE		LDA		PBE		LDA	PBE	
	avg	stdev	avg	stdev	a_0 (Å)	b	a_0 (Å)	b			
CeO_2	1.0819 ^a	0.0001	1.1257 ^a	0.0004	1.11	5.3623 ^b		5.4629 ^b		2.017	1.715
LZO						10.6923 ^c		10.8906 ^c		1.774	1.542
C	0.9243	0.0137	1.0096	0.0130	–	5.3656	–0.4161	5.4657	–0.3077	1.528	1.235
Si	0.7951	0.0052	0.8321	0.0044	–	5.3626	–0.6688	5.4643	–0.6936	2.057	1.738
Ge	0.8786	0.0031	0.9270	0.0034	–	5.3618	–0.4640	5.4631	–0.4578	1.909	1.573
Sn	0.9764	0.0020	1.0199	0.0049	0.95	5.3618	–0.2383	5.4629	–0.2400	2.004	1.692
Pb	1.0686	0.0034	1.1293	0.0042	1.08	5.3612	–0.0174	5.4633	0.0050	1.845	1.516
Ti	0.8421	0.0043	0.8862	0.0050	0.88	5.3629	–0.5640	5.4644	–0.5706	2.145	1.825
Zr	0.9548	0.0019	0.9791	0.0052	0.98	5.3622	–0.2938	5.4634	–0.3409	2.153	1.878
Hf	0.9205	0.0023	0.9612	0.0056	0.97	5.3622	–0.3733	5.4635	–0.3849	2.194	1.881
Cu	0.9131	0.0024	0.9907	0.0064	0.91 ^e / _– ^h	5.3624	–0.3947	5.4627	–0.3065	1.704	1.374
Zn	0.9518	0.0046	1.0277	0.0077	0.88 ^f / _{1.04} ⁱ	5.3632	–0.3173	5.4640	–0.2389	1.712	1.410
La	1.1858	0.0011	1.2421	0.0043	1.17 ^g / _{1.30} ^j	5.3623	0.2374	5.4637	0.2597	1.835	1.556

^a The Ce radius is calculated using Eq. (1), where the 4-coordinated Shannon crystal radius for oxygen is taken as 1.24 Å [26]. ^b, ^c The actual lattice parameter as calculated from the pure, relaxed geometries of CeO_2 and LZO. Note that the LZO lattice parameter is double the CeO_2 lattice parameter. ^d The bulk modulus for Cu dopant concentration of 12.5%. ^e, ^f, ^g Shannon crystal radii for 6-coordinated Cu^{1+} , Zn^{2+} , and La^{3+} . ^h, ⁱ, ^j Shannon crystal radii for 8-coordinated Cu^{1+} , Zn^{2+} , and La^{3+} .

with the PBE values always slightly larger than the LDA ones, as one would expect. Due to the underbinding nature of GGA functionals such as PBE and the overbinding nature of LDA, we expect the LDA and PBE values to be a slight under- and overestimation of the actual crystal radius, respectively. Comparison of the calculated dopant radii to the Shannon crystal radii for eight-coordinated tetravalent atoms R_{sh}^8 shows a very good correlation. This indicates that the Shannon crystal radius is an excellent parametrization to predict the lattice expansion of doped CeO_2 .

Based on lattice parameters obtained from the *ab initio* calculations for the different dopant concentrations, a fitting of Vegard's law is done for each of the group IV elements. Table 1 shows the intercept a_0 and the slope b of this linear fitting. For the LDA results, the fitted curves of the lattice parameter as function of the dopant concentration n_x are shown in Fig. 2. With the exception of Pb, all systems show a nearly perfect fit, with correlation coefficient (R^2) values better than 0.99 for both LDA and PBE calculations. The poor fit of Pb is related to the negligible expansion of the lattice. As a result, small deviations can transform an expansion into a contraction going from one concentration to the next. A zero expansion can thus be assumed for Pb doping. The high quality of the other linear fits, with intercepts that are within 0.01 Å of the CeO_2 lattice parameter, shows that the analytically obtained Vegard's law is a good model for the lattice expansion in these doped systems.

Both LDA and PBE results show the same qualitative behavior, and the optimum substitution concentrations, for lattice parameter matching with LZO, are ~5% for all group IV elements, with, due to its negligible contraction, the exception of Pb substitution.

Table 1 also shows the bulk modulus, obtained for substituent concentrations of 25%. If we assume the bulk modulus to behave linearly with regard to the dopant concentration (*cf.* next section), then it is possible to estimate the optimum dopant concentration which would result in a perfect matching of the bulk modulus of the doped CeO_2 and LZO. For the elements of group IVb, Table 1 shows a bulk modulus which is larger than that of CeO_2 . This makes bulk modulus matching with LZO, which has a smaller bulk modulus, impossible. In addition, the bulk modulus seems to increase very slightly with increasing atomic number. The group IVa elements show a more complex behavior. With the exception of Si, all group IVa elements lower the bulk modulus of CeO_2 . However, the effect is generally too small to allow for a bulk modulus matching at reasonable dopant concentrations. In case of the IVa elements,

the bulk modulus is lowered with the introduction of every newly filled shell (d for Ge and Sn, and f for Pb), while it increases with increasing atomic radii. Combining the results of the groups IVa and IVb shows that not only the valency electrons but also electrons in filled shells near the Fermi level play a crucial role for the bulk modulus.

3.3. Aliovalent dopants without vacancies

We have also investigated the effect of doping with aliovalent elements, but this without the introduction of charge compensating vacancies. This makes comparison between aliovalent and group IV elements more straightforward. The three aliovalent elements we have investigated are: Cu, Zn, and La. (The effect of the addition of charge compensating vacancies is a topic on its own, and will therefore be discussed elsewhere.)

If we look at the calculated atomic radii in Table 1, we see that unlike with the group IV elements, the values are smaller than the Shannon crystal radii for 8-coordinated atoms, but larger than the values for 6-coordinated atoms.² This would indicate that the lower valence results in a lower coordination, regardless of the geometric and chemical surrounding. This in turn should give rise to charge redistribution near the defect.

Just as for the group IV elements, the obtained lattice parameters for different concentrations can be fitted nicely against a linear Vegard law, with R^2 values better than 0.99. This means that under oxidizing atmosphere, *i.e.* with little or no oxygen vacancies in the system, also aliovalent dopants should show a linear concentration dependence of the lattice parameter. As for the group IV elements lattice parameter matching with LZO is found to be ~5% for Cu and Zn. For La doping, which shows a lattice expansion, no lattice parameter matching with LZO is possible.

In case of Cu, we calculated the bulk modulus for dopant concentrations of 25.0 and 12.5%, shown in Table 1. Taking the CeO_2 bulk modulus as the case of 0.0% doping, a nearly linear trend is observed. Although all three aliovalent elements show a decrease of the bulk modulus which looks slightly better than is the case for

² Extrapolating the tabulated Shannon crystal radius values for Cu^{1+} to the coordination number 8 would give a value in the range of 1.05–1.11 Å.

the group IV elements, very high dopant concentrations would still be needed to have bulk modulus matching with LZO.

Combined with the results for the group IV elements, it is clear that the lattice parameter is only influenced by the (Shannon) crystal radius of the doping elements, while the bulk modulus is also strongly influenced by the electronic structure (compare Zn/Zr and Hf/Cu).

4. Conclusion

The influence of group IV and aliovalent dopants on the lattice parameter and bulk modulus of CeO₂ are investigated using DFT calculations. A Vegard's law relation is analytically derived for doped CeO₂ without oxygen vacancies. Lattice parameters obtained from DFT calculations for different dopant concentrations show that for both group IV and aliovalently doped systems without oxygen vacancies the lattice expansion is described by a linear relation. This Vegard's law can be predicted from the Shannon crystal radius of the dopant element. Optimum doping concentrations for lattice parameter matching with LZO is about 5 % for the different dopants studied, the exceptions being Pb and La. The former shows no appreciable expansion or contraction of the CeO₂ lattice parameter, while the latter results in a lattice expansion. It is shown that group IVb dopants result in a slight increase in the bulk modulus, while group IVa, except Si, and the aliovalent dopants show a decrease in the bulk modulus of CeO₂. The decrease, however, is insufficient to obtain bulk modulus matching at concentrations similar to those needed for lattice parameter matching with LZO.

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